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SBAS334D –NOVEMBER 2004–REVISED JULY 2016

DAC5675A 14-Bit, 400-MSPS Digital-to-Analog Converter

Technical [Documents](http://www.ti.com/product/DAC5675A?dcmp=dsproject&hqs=td&#doctype2)

Tools & [Software](http://www.ti.com/product/DAC5675A?dcmp=dsproject&hqs=sw&#desKit)

1 Features

- ¹• 400MSPS Update Rate
- LVDS-Compatible Input Interface
- Spurious-Free Dynamic Range (SFDR) to Nyquist:
	- 69dBc at 70MHz IF, 400MSPS
- W-CDMA Adjacent Channel Power Ratio (ACPR): – 73dBc at 30.72MHz IF, 122.88MSPS
	- 71dBc at 61.44MHz IF, 245.76MSPS
- Differential Scalable Current Sink Outputs: 2mA to 20mA
- On-Chip 1.2V Reference
- Single 3.3V Supply Operation
- Power Dissipation: 660mW at $f_{\text{C-K}}$ = 400MSPS, $f_{\text{OUT}} = 20$ MHz
- Package: 48-Pin HTQFP PowerPad™, $T_{JA} = 28.8^{\circ}$ C/W

2 Applications

- Cellular Base Transceiver Station Transmit Channel:
	- CDMA: WCDMA, CDMA2000, IS-95
	- TDMA: GSM, IS-136, EDGE/GPRS
	- Supports Single-Carrier and Multicarrier Applications
- • Test and Measurement: Arbitrary Waveform Generation
- Direct Digital Synthesis (DDS)
- Cable Modem Headend

3 Description

The DAC5675A is a 14-bit resolution high-speed digital-to-analog converter. The DAC5675A is designed for high-speed digital data transmission in wired and wireless communication systems, highfrequency direct-digital synthesis (DDS), and waveform reconstruction in test and measurement applications. The DAC5675A has excellent spuriousfree dynamic range (SFDR) at high intermediate frequencies, which makes the DAC5675A well-suited for multicarrier transmission in TDMA- and CDMAbased cellular base transceiver stations (BTSs).

The DAC5675A operates from a single-supply voltage of 3.3 V. Power dissipation is 660 mW at f_{CLK} = 400 MSPS, f_{OUT} = 70 MHz. The DAC5675A provides a nominal full-scale differential current output of 20mA, supporting both single-ended and differential applications. The output current can be directly fed to the load with no additional external output buffer required. The output is referred to the analog supply voltage AV_{DD} .

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The DAC5675A comprises a low-voltage differential signaling (LVDS) interface for high-speed digital data input. LVDS features a low differential voltage swing with a low constant power consumption across frequency, allowing for high-speed data transmission with low noise levels; that is, with low electromagnetic interference (EMI). LVDS is typically implemented in low-voltage digital CMOS processes, making it the ideal technology for high-speed interfacing between the DAC5675A and high-speed low-voltage CMOS ASICs or FPGAs. The DAC5675A current-sink-array architecture supports update rates of up to 400MSPS. On-chip edge-triggered input latches provide for minimum setup and hold times, thereby relaxing interface timing.

Device Information[\(1\)](#page-0-0)

(1) For all available packages, see the orderable addendum at the end of the data sheet.

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Simple Schematic

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4 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

Changes from Revision C (March 2005) to Revision D Page Page Propose 2005) to Revision D

5 Description Continued

 \mathfrak{p}

The DAC5675A has been specifically designed for a differential transformer-coupled output with a 50 Ω doublyterminated load. With the 20 mA full-scale output current, both a 4:1 impedance ratio (resulting in an output power of 4 dBm) and 1:1 impedance ratio transformer (–2 dBm) are supported. The last configuration is preferred for optimum performance at high output frequencies and update rates. The outputs are terminated to AVDD and have voltage compliance ranges from AV_{DD} –1 to AV_{DD} + 0.3 V.

An accurate on-chip 1.2-V temperature-compensated bandgap reference and control amplifier allows the user to adjust this output current from 20 mA down to 2 mA. This provides 20-dB gain range control capabilities. Alternatively, an external reference voltage may be applied. The DAC5675A features a SLEEP mode, which reduces the standby power to approximately 18 mW.

The DAC5675A is available in a 48-pin HTQFP thermally-enhanced PowerPad package. This package increases thermal efficiency in a standard size IC package. The device is characterized for operation over the industrial temperature range of –40°C to +85°C.

[DAC5675A](http://www.ti.com/product/dac5675a?qgpn=dac5675a) www.ti.com SBAS334D –NOVEMBER 2004–REVISED JULY 2016

6 Pin Configuration and Functions

Note: Thermal pad size: 4.5 mm x 4.5 mm (min), 5.5 mm x 5.5 mm (max)

Pin Functions

7 Specifications

7.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)⁽¹⁾

(1) Stresses above those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. Exposure outside of absolute maximum conditions for extended periods may degrade device reliability. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under recommended operating conditions is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

(2) Measured with respect to AGND.
(3) Measured with respect to DGND.

Measured with respect to DGND.

7.2 ESD Ratings

(1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

(2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

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7.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

7.4 Thermal Information

(1) For more information about traditional and new thermal metrics, see the SPRA953*[Semiconductor and IC Package Thermal Metrics](http://www.ti.com/lit/pdf/spra953)* application report.

7.5 DC Electrical Characteristics

Over operating free-air temperature range. Typical values at +25°C, $AV_{DD} = 3.3V$, $DV_{DD} = 3.3V$, $I_{O(FS)} = 20mA$, unless otherwise noted.

(1) Measured differential at I_{OUT1} and I_{OUT2} ; 25 Ω to AV_{DD}.
(2) Use an external buffer amplifier with high impedance in
(3) Measured at $f_{\text{CLK}} = 400\text{MSPS}$ and $f_{\text{OUT}} = 70\text{MHz}$.

(2) Use an external buffer amplifier with high impedance input to drive any external load.

(3) Measured at $f_{CLK} = 400MSPS$ and $f_{OUT} = 70MHz$.

7.6 AC Electrical Characteristics

Over operating free-air temperature range. Typical values at +25°C, AV_{DD} = 3.3V, DV_{DD} = 3.3V, I_{O(FS)} = 20mA, differential transformer-coupled output, 50 Ω doubly-terminated load, unless otherwise noted.

(1) Noise averaged up to 400MHz when operating at 400MSPS.

(2) See [Figure 9.](#page-10-0)

(3) See [Figure 10](#page-10-0).

(4) See [Figure 12](#page-10-1)

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TRUMENTS

EXAS

7.7 Digital Specifications

Over operating free-air temperature range. Typical values at +25°C, $AV_{DD} = 3.3V$, $DV_{DD} = 3.3V$, unless otherwise noted.

7.8 Operational Characteristics(1)

Over operating free-air temperature range, $AV_{DD} = 3.3V$, $DV_{DD} = 3.3V$, $I_{O(FS)} = 20mA$, unless otherwise noted.

(1) Specifications subject to change.

 -50% $\cancel{\text{+}}50\%$ Valid Data D[13:0]A D[13:0]B CLK CLKC DAC Output I_{OUT} $1/I_{\text{OUT}}$ 2 t_{SU} \mathfrak{t}_H t_{PD} $t_{S(DAC)}$ t_{r(IOUT)} $\mathfrak{t}_{\mathrm{DD}}$ 0.1% 0.1% $\frac{1}{1}$ 50% 10% 90%

Figure 2. LVDS Timing Test Circuit and Input Test Levels

[DAC5675A](http://www.ti.com/product/dac5675a?qgpn=dac5675a) SBAS334D –NOVEMBER 2004–REVISED JULY 2016 **www.ti.com**

7.9 Typical Characteristics

Typical Characteristics (continued)

8 Detailed Description

8.1 Overview

The DAC5675A is a 14-bit resolution high-speed digital-to-analog converter. The DAC5675A is designed or highspeed digital data transmission in wired and wireless communication systems, high frequency direct-digital synthesis (DDS), and waveform reconstruction in test and measurement applications. The DAC5675A has excellent spurious free dynamic range (SFDR) at high intermediate frequencies, which makes the DAC5675A well-suited for multicarrier transmission in TDMA- and CDMA based cellular base transceiver stations (BTSs).

8.2 Functional Block Diagram

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8.3 Feature Description

8.3.1 Digital Inputs

The DAC5675A uses a low voltage differential signaling (LVDS) bus input interface. The LVDS features a low differential voltage swing with low constant power consumption (≉4mA per complementary data input) across frequency. The differential characteristic of LVDS allows for high-speed data transmission with low electromagnetic interference (EMI) levels. The LVDS input minimum and maximum input threshold table lists the LVDS input levels. [Figure 13](#page-12-0) shows the equivalent complementary digital input interface for the DAC5675A, valid for pins D[13:0]A and D[13:0]B. Note that the LVDS interface features internal 110Ω resistors for proper termination. [Figure 2](#page-8-0) shows the LVDS input timing measurement circuit and waveforms. A common-mode level of 1.2V and a differential input swing of $0.8V_{PP}$ is applied to the inputs.

[Figure 14](#page-12-1) shows a schematic of the equivalent CMOS/TTL-compatible digital inputs of the DAC5675A, valid for the SLEEP pin.

Figure 13. LVDS Digital Equivalent Input

8.3.2 Clock Input

The DAC5675A features differential, LVPECL compatible clock inputs (CLK, CLKC). [Figure 15](#page-13-0) shows the equivalent schematic of the clock input buffer. The internal biasing resistors set the input common-mode voltage to approximately 2V, while the input resistance is typically 670Ω. A variety of clock sources can be ac-coupled to the device, including a sine wave source (see [Figure 16](#page-13-1)).

Figure 15. Clock Equivalent Input

Figure 16. Driving the DAC5675A with a Single-Ended Clock Source Using a Transformer

To obtain best ac performance the DAC5675A clock input should be driven with a differential LVPECL or sine wave source as shown in [Figure 17](#page-14-0) and [Figure 18](#page-14-1). Here, the potential of V_{TT} should be set to the termination voltage required by the driver along with the proper termination resistors (R_T) . The DAC5675A clock input can also be driven single-ended; this is shown in [Figure 19.](#page-14-2)

Figure 17. Driving the DAC5675A with a Single-Ended ECL/PECL Clock Source

Figure 19. Driving the DAC5675A with a Single-Ended TTL/CMOS Clock Source

8.3.3 Supply Inputs

The DAC5675A comprises separate analog and digital supplies, that is, AV_{DD} and DV_{DD} , respectively. These supply inputs can be set independently from 3.6V down to 3.15V.

8.3.4 DAC Transfer Function

The DAC5675A has a current sink output. The current flow through IOUT1 and IOUT2 is controlled by D[13:0]A and D[13:0]B. For ease of use, we denote D[13:0] as the logical bit equivalent of D[13:0]A and its complement D[13:0]B. The DAC5675A supports straight binary coding with D13 being the MSB and D0 the LSB. Full-scale current flows through IOUT2 when all D[13:0] inputs are set high and through IOUT1 when all D[13:0] inputs are set low. The relationship between IOUT1 and IOUT2 can be expressed as [Equation 1:](#page-15-0)

$$
IOUT1 = IO_{(FS)} - IOUT2
$$

(1)

 $IO_{(FS)}$ is the full-scale output current sink (2mA to 20mA). Since the output stage is a current sink, the current can only flow from AV_{DD} through the load resistors R_L into the IOUT1 and IOUT2 pins.

The output current flow in each pin driving a resistive load can be expressed as shown in [Figure 20](#page-15-1), as well as in [Equation 2](#page-15-2) and [Equation 3.](#page-15-3)

$$
IOUT1 = \frac{IO_{(FS)} \times (16383 - CODE)}{16384}
$$

\n
$$
IOUT2 = \frac{IO_{(FS)} \times CODE}{16384}
$$
 (2)

where CODE is the decimal representation of the DAC input word. This would translate into single-ended voltages at IOUT1 and IOUT2, as shown in [Equation 4](#page-15-4) and [Equation 5:](#page-15-5)

Assuming that D[13:0] = 1 and the R_L is 50 Ω , the differential voltage between pins IOUT1 and IOUT2 can be expressed as shown in [Equation 6](#page-15-6) through [Equation 8](#page-15-7):

If $D[13:0] = 0$, then IOUT2 = 0mA and IOUT1 = 20mA and the differential voltage VDIFF = -1V.

The output currents and voltages in IOUT1 and IOUT2 are complementary. The voltage, when measured differentially, will be doubled compared to measuring each output individually. Care must be taken not to exceed the compliance voltages at the IOUT1 and IOUT2 pins in order to keep signal distortion low.

8.3.5 Reference Operation

The DAC5675A has a bandgap reference and control amplifier for biasing the full-scale output current. The fullscale output current is set by applying an external resistor $R_{B|AS}$. The bias current $I_{B|AS}$ through resistor $R_{B|AS}$ is defined by the on-chip bandgap reference voltage and control amplifier. The full-scale output current equals 16 times this bias current. The full-scale output current $IO_{(FS)}$ is thus expressed as [Equation 9](#page-16-0):

$$
IO_{(FS)} = 16 \times I_{BIAS} = \frac{16 \times V_{EXTIO}}{R_{BIAS}}
$$

[DAC5675A](http://www.ti.com/product/dac5675a?qgpn=dac5675a)

(9)

where V_{EXTIO} is the voltage at terminal EXTIO. The bandgap reference voltage delivers a stable voltage of 1.2 V. This reference can be overridden by applying an external voltage to terminal EXTIO. The bandgap reference can additionally be used for external reference operation. In such a case, an external buffer amplifier with high impedance input should be selected in order to limit the bandgap load current to less than 100 nA. The capacitor C_{FXT} may be omitted. Terminal EXTIO serves as either an input or output node. The full-scale output current is adjustable from 20mA down to 2mA by varying resistor R_{BIAS} .

8.3.6 Analog Current Outputs

[Figure 21](#page-16-1) shows a simplified schematic of the current sink array output with corresponding switches. Differential NPN switches direct the current of each individual NPN current sink to either the positive output node IOUT1 or its complementary negative output node IOUT2. D[13:0] controls the S(N)C current switches and D[13:0] controls the S(N) current switches, as explained in the previous *DAC Transfer Function* section (see [Figure 20](#page-15-1)). The output impedance is determined by the stack of the current sinks and differential switches, and is > 300kΩ in parallel with an output capacitance of 5pF.

The external output resistors are referred to the positive supply AV_{DD} .

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Figure 21. Equivalent Analog Current Output

The DAC5675A can easily be configured to drive a doubly-terminated 50Ω cable using a properly selected transformer. [Figure 22](#page-17-0) and [Figure 23](#page-17-1) show the 1:1 and 4:1 impedance ratio configuration, respectively. These configurations provide maximum rejection of common-mode noise sources and even-order distortion components, thereby doubling the power of the DAC to the output. The center tap on the primary side of the transformer is terminated to AV_{DD} , enabling a dc current flow for both IOUT1 and IOUT2. Note that the ac performance of the DAC5675A is optimum and specified using a 1:1 differential transformer-coupled output.

Figure 22. Driving a Doubly-Terminated 50Ω Cable Using a 1:1 Impedance Ratio Transformer

Figure 23. Driving a Doubly-Terminated 50Ω Cable Using a 4:1 Impedance Ratio Transformer

[Figure 24](#page-18-1)(a) shows the typical differential output configuration with two external matched resistor loads. The nominal resistor load of 25 Ω gives a differential output swing of $1V_{PP}$ (0.5–V_{PP} single-ended) when applying a 20 mA full-scale output current. The output impedance of the DAC5675A slightly depends on the output voltage at nodes IOUT1 and IOUT2. Consequently, for optimum dc-integral nonlinearity, the configuration of [Figure 24](#page-18-1)(b) should be chosen. In this current/voltage (I-V) configuration, terminal IOUT1 is kept at AV_{DD} by the inverting operational amplifier. The complementary output should be connected to AV_{DD} to provide a dc-current path for the current sources switched to IOUT1. The amplifier maximum output swing and the full-scale output current of the DAC determine the value of the feedback resistor (R_{FB}) . The capacitor (C_{FB}) filters the steep edges of the DAC5675A current output, thereby reducing the operational amplifier slew-rate requirements. In this configuration, the op amp should operate at a supply voltage higher than the resistor output reference voltage AV_{DD} as a result of its positive and negative output swing around AV_{DD} . Node IOUT1 should be selected if a single-ended unipolar output is desired.

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Figure 24. Output Configurations

8.4 Device Functional Modes

8.4.1 Sleep Mode

The DAC5675A features a power-down mode that turns off the output current and reduces the supply current to approximately 6mA. The power-down mode is activated by applying a logic level 1 to the SLEEP pin pulled down internally.

ISTRUMENTS

9 Application and Implementation

NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

9.1 Application Information

[Figure 25](#page-19-3) shows a simplified block diagram of the current steering DAC5675A. The DAC5675A consists of a segmented array of NPN-transistor current sinks, capable of delivering a full-scale output current up to 20 mA. Differential current switches direct the current of each current sink to either one of the complementary output nodes IOUT1 or IOUT2. The complementary current output enables differential operation, canceling out common-mode noise sources (digital feed-through, on-chip and PCB noise), dc offsets, and even-order distortion components, and doubling signal output power.

The full-scale output current is set using an external resistor (R_{BAS}) in combination with an on-chip bandgap voltage reference source (1.2 V) and control amplifier. The current (I_{BIAS}) through resistor R_{BIAS} is mirrored internally to provide a full-scale output current equal to 16 times I_{BIAS} . The full-scale current is adjustable from 20 mA down to 2 mA by using the appropriate bias resistor value.

9.2 Typical Application

A typical application for the DAC5675a is as dual or single carrier transmitter. The DAC is provided with some input digital baseband signal and it outputs an analog carrier.

Figure 25. Application Schematic

Typical Application (continued)

9.2.1 Design Requirements

The requirements for this design were to generate a 2-carrier WCDMA signal at an intermediate frequency of 92.16 MHz. The ACPR needs to be better than 65 dBc. For this design example use the parameters shown in [Table 1.](#page-20-1)

Table 1. Design Parameters

9.2.2 Detailed Design Procedure

The 2-carrier signal with an intermediate frequency of 92.16 MHz must be created in the digital processor at a sample rate of 368.64 Msps for DAC. These 14 bit samples are placed on the 14b LVDS input port of the DAC.

A differential DAC clock must be generated from a clock source at 368.64 MHz. This must be provided to the CLKIN pins of the DAC.

The IOUOTA and IOUTB differential connections must be connected to a transformer to provide a single ended output. A typical 1:1 impedance transformer is used on the device EVM. The DAC5675AEVM [\(SLAU080](http://www.ti.com/lit/pdf/SLAU080)) provides a good reference for this design example.

9.2.3 Application Curves

This spectrum analyzer plot shows the ACPR for the transformer output 2-carrier signal with intermediate frequency of 92.16 MHz. The results meet the system requirements for a minimum of 65 dBc ACPR.

Figure 26. W-CDMA TM1 Dual Carrier Power vs Frequency

10 Power Supply Recommendations

It is recommended that the device be powered with the nominal supply voltages as indicated in the [Recommended Operating Conditions.](#page-4-0)

In most instances the best performance is achieved with LDO supplies. However the supplies may be driven with direct outputs from a DC-DC switcher as long as the noise performance of the switcher is acceptable.

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11 Layout

11.1 Layout Guidelines

The DAC5675 EVM layout should be used as a reference for the layout to obtain the best performance. A sample layout is shown in [Figure 27](#page-21-3). Some important layout recommendations are:

- Use a single ground plane. Keep the digital and analog signals on distinct separate sections of the board. This may be virtually divided down the middle of the device package when doing placement and layout.
- Keep the analog outputs as far away from the switching clocks and digital signals as possible. This will keep coupling from the digital circuits to the analog outputs to a minimum.
- Decoupling caps should be kept close to the power pins of the device.

11.2 Layout Example

Figure 27. Top Layer of DAC5675A EVM Layout

Layout Example (continued)

Figure 28. Bottom Layer of DAC5675A EVM Layout

12 Device and Documentation Support

12.1 Receiving Notification of Documentation Updates

To receive notification of documentation updates — go to the product folder for your device on ti.com. In the upper right-hand corner, click the *Alert me* button to register and receive a weekly digest of product information that has changed (if any). For change details, check the revision history of any revised document.

12.2 Community Resources

The following links connect to TI community resources. Linked contents are provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's [Terms of](http://www.ti.com/corp/docs/legal/termsofuse.shtml) [Use.](http://www.ti.com/corp/docs/legal/termsofuse.shtml)

[TI E2E™ Online Community](http://e2e.ti.com) *TI's Engineer-to-Engineer (E2E) Community.* Created to foster collaboration among engineers. At e2e.ti.com, you can ask questions, share knowledge, explore ideas and help solve problems with fellow engineers.

[Design Support](http://support.ti.com/) *TI's Design Support* Quickly find helpful E2E forums along with design support tools and contact information for technical support.

12.3 Trademarks

PowerPad, E2E are trademarks of Texas Instruments. All other trademarks are the property of their respective owners.

12.4 Electrostatic Discharge Caution

These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

12.5 Glossary

[SLYZ022](http://www.ti.com/lit/pdf/SLYZ022) — *TI Glossary*.

This glossary lists and explains terms, acronyms, and definitions.

12.6 Device Nomenclature

12.6.1 Definitions of Specifications and Terminology

Gain error is defined as the percentage error in the ratio between the measured full-scale output current and the value of 16 x $V_{(EXTIO)}/R_{BIAS}$. A $V_{(EXTIO)}$ of 1.25V is used to measure the gain error with an external reference voltage applied. With an internal reference, this error includes the deviation of $V_{(EXT|O)}$ (internal bandgap reference voltage) from the typical value of 1.25V.

Offset error is defined as the percentage error in the ratio of the differential output current (IOUT1–IOUT2) and the half of the full-scale output current for input code 8192.

THD is the ratio of the rms sum of the first six harmonic components to the rms value of the fundamental output signal.

SNR is the ratio of the rms value of the fundamental output signal to the rms sum of all other spectral components below the Nyquist frequency, including noise, but excluding the first six harmonics and dc.

SINAD is the ratio of the rms value of the fundamental output signal to the rms sum of all other spectral components below the Nyquist frequency, including noise and harmonics, but excluding dc.

ACPR or adjacent channel power ratio is defined for a 3.84Mcps 3GPP W-CDMA input signal measured in a 3.84MHz bandwidth at a 5MHz offset from the carrier with a 12dB peak-to-average ratio.

APSSR or analog power supply ratio is the percentage variation of full-scale output current versus a 5% variation of the analog power supply AV_{DD} from the nominal. This is a dc measurement.

DPSSR or digital power supply ratio is the percentage variation of full-scale output current versus a 5% variation of the digital power supply DV_{DD} from the nominal. This is a dc measurement.

13 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

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PACKAGING INFORMATION

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

⁽²⁾ RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures. "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

(3) MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

OTHER QUALIFIED VERSIONS OF DAC5675A :

PACKAGE OPTION ADDENDUM

• Space: [DAC5675A-SP](http://focus.ti.com/docs/prod/folders/print/dac5675a-sp.html)

NOTE: Qualified Version Definitions:

• Space - Radiation tolerant, ceramic packaging and qualified for use in Space-based application

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PACKAGE MATERIALS INFORMATION

TRAY

Chamfer on Tray corner indicates Pin 1 orientation of packed units.

*All dimensions are nominal

7 x 7, 0.5 mm pitch QUAD FLATPACK

GENERIC PACKAGE VIEW

PHP 48 TQFP - 1.2 mm max height

This image is a representation of the package family, actual package may vary. Refer to the product data sheet for package details.

PHP (S-PQFP-G48)

PowerPAD[™] PLASTIC QUAD FLATPACK

NOTES: A. All linear dimensions are in millimeters.

- This drawing is subject to change without notice. **B.**
- Body dimensions do not include mold flash or protrusion С.
- This package is designed to be soldered to a thermal pad on the board. Refer to Technical Brief, PowerPad D. Thermally Enhanced Package, Texas Instruments Literature No. SLMA002 for information regarding
recommended board layout. This document is available at www.ti.com <http://www.ti.com>.
- E. Falls within JEDEC MS-026

PowerPAD is a trademark of Texas Instruments.

$(S-PQFP-G48)$ PowerPAD[™] PLASTIC QUAD FLATPACK PHP.

THERMAL INFORMATION

This PowerPAD™ package incorporates an exposed thermal pad that is designed to be attached to a printed
circuit board (PCB). The thermal pad must be soldered directly to the PCB. After soldering, the PCB can be used as a heatsink. In addition, through the use of thermal vias, the thermal pad can be attached directly to the appropriate copper plane shown in the electrical schematic for the device, or alternatively, can be attached to a special heatsink structure designed into the PCB. This design optimizes the heat transfer from the integrated circuit (IC).

For additional information on the PowerPAD package and how to take advantage of its heat dissipating abilities, refer to Technical Brief, PowerPAD Thermally Enhanced Package, Texas Instruments Literature No. SLMA002 and Application Brief, PowerPAD Made Easy, Texas Instruments Literature No. SLMA004. Both documents are available at www.ti.com.

The exposed thermal pad dimensions for this package are shown in the following illustration.

NOTE: A. All linear dimensions are in millimeters

PowerPAD is a trademark of Texas Instruments

PHP (S-PQFP-G48)

PowerPAD[™] PLASTIC QUAD FLATPACK

NOTES: All linear dimensions are in millimeters. A.

- This drawing is subject to change without notice. **B.**
- Publication IPC-7351 is recommended for alternate designs. C.
- D. This package is designed to be soldered to a thermal pad on the board. Refer to Technical Brief, PowerPad Thermally Enhanced Package, Texas Instruments Literature No. SLMA002, SLMA004, and also the Product Data Sheets
for specific thermal information, via requirements, and recommended board layout. These documents are availabl www.ti.com <http://www.ti.com>.
- E. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil desian recommendations. Refer to IPC 7525 for stencil desian considerations.
- F. Customers should contact their board fabrication site for recommended solder mask tolerances and via tenting options for vias placed in the thermal pad.

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